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ILNAS-EN IEC/IEEE 63195-2:2023

Assessment of power density of human exposure to radio frequency fields from wireless devices in close proximity to the head and body

Bewertung der Leistungsdichte der
Exposition des Menschen gegenüber
hochfrequenten Feldern von drahtlosen
Geräten in unmittelbarer Nähe des

Évaluation de la densité de puissance de
l'exposition humaine aux champs
radiofréquences provenant de dispositifs
sans fil à proximité immédiate de la tête

01/2023



National Foreword

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Assessment of power density of human exposure to radio
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Computational procedure
(IEC/IEEE 63195-2:2022)

Évaluation de la densité de puissance de l'exposition
humaine aux champs radiofréquences provenant de
dispositifs sans fil à proximité immédiate de la tête et du
corps (plage de fréquences de 6 GHz à 300 GHz) - Partie
2: Procédure de calcul
(IEC/IEEE 63195-2:2022)

Bewertung der Leistungsdichte der Exposition des
Menschen gegenüber hochfrequenten Feldern von
drahtlosen Geräten in unmittelbarer Nähe des Kopfes und
des Körpers (Frequenzbereich von 6 GHz bis 300 GHz) -
Teil 2: Berechnungsverfahren
(IEC/IEEE 63195-2:2022)

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European foreword

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The following dates are fixed:

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IEC/IEEE 62209-1528:2020 NOTE Harmonized as EN IEC/IEEE 62209-1528:2021 (not modified)

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC/IEEE 62704-1	2017	Determining the peak spatial-average specific absorption rate (SAR) in the human body from wireless communications devices, 30 MHz to 6 GHz - Part 1: General requirements for using the finite difference time-domain (FDTD) method for SAR calculations	-	-
IEC/IEEE 62704-4	2020	Determining the peak spatial-average specific absorption rate (SAR) in the human body from wireless communication devices, 30 MHz to 6 GHz - Part 4: General requirements for using the finite element method for SAR calculations	-	-
IEC/IEEE 63195-1	2022	Assessment of power density of human exposure to radio frequency fields from wireless devices in close proximity to the head and body (frequency range of 6 GHz to 300 GHz) - Part 1: Measurement procedure	EN IEC/IEEE 63195-1	2023
IEEE 145	-	Definitions of terms for antennas	-	-



INTERNATIONAL STANDARD

NORME INTERNATIONALE



Assessment of power density of human exposure to radio frequency fields from wireless devices in close proximity to the head and body (frequency range of 6 GHz to 300 GHz) –

Part 2: Computational procedure

Évaluation de la densité de puissance de l'exposition humaine aux champs radiofréquences provenant de dispositifs sans fil à proximité immédiate de la tête et du corps (plage de fréquences de 6 GHz à 300 GHz) –

Partie 2: Procédure de calcul

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